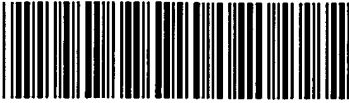


Search Notes

Application/Control No.

10/705,238

Examiner

Matthew G. Kayrish

Applicant(s)/Patent under
Reexamination

JANG ET AL.

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EASt (See Attached Search History)	4/2/2007	MK